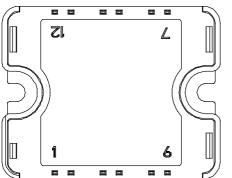


# Full - Bridge NPT IGBT Power Module



### 3 4 $\bigcirc$ Q3 Q1 CR1 CR3 6 Q4 Q2 CR2 CR4 9 8 10 С $\overline{\mathcal{M}}$ ()NTC 12 11



Pins 3/4 must be shorted together

# Absolute maximum ratings

### Symbol Parameter Max ratings Unit V<sub>CES</sub> Collector - Emitter Breakdown Voltage 600 V $T_C = 25^{\circ}C$ 42 $I_{C}$ Continuous Collector Current $T_C = 80^{\circ}C$ 30 А Pulsed Collector Current $T_C = 25 \overline{C}$ 100 $I_{CM}$ Gate - Emitter Voltage V<sub>GE</sub> ±20 V W Maximum Power Dissipation $T_C = 25^{\circ}C$ 140 $P_{D}$ RBSOA Reverse Bias Safe Operating Area $T_i = 125^{\circ}C$ 60A@500V

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

### Features

- Non Punch Through (NPT) Fast IGBT
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 100 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
  - Very low stray inductance
  - Symmetrical design
- Internal thermistor for temperature monitoring
- High level of integration

### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Each leg can be easily paralleled to achieve a phase leg of twice the current capability
- RoHS Compliant

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# All ratings (a) $T_i = 25^{\circ}C$ unless otherwise specified

### **Electrical Characteristics** Symbol **Characteristic Test Conditions** Min Тур Max Unit $V_{GE} = 0\overline{V}$ $T_i = 25^{\circ}C$ 250 ICES Zero Gate Voltage Collector Current μΑ $V_{CE} = 600V$ $T_i = 125^{\circ}C$ 500 $T_i = 25^{\circ}C$ $V_{GE} = 15V$ 1.7 2.45 2.0 V<sub>CE(on)</sub> V Collector Emitter on Voltage $I_{C} = 30A$ $T_i = 125^{\circ}C$ 2.2 $V_{GE} = V_{CE}, I_C = 1 \text{mA}$ V<sub>GE(th)</sub> Gate Threshold Voltage V 4 6 I<sub>GES</sub> Gate - Emitter Leakage Current $V_{GE} = 20V, V_{CE} = 0V$ 400 nA

# **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$ $V_{CE} = 25V$ $f = 1MHz$			1350		
C <sub>oes</sub>	Output Capacitance				193		pF
C <sub>res</sub>	Reverse Transfer Capacitance				120		
Qg	Total gate Charge	$V_{GE} = 15V$ $V_{Bus} = 300V$			99		
Q <sub>ge</sub>	Gate – Emitter Charge				10		nC
Q <sub>gc</sub>	Gate – Collector Charge	I <sub>C</sub> =30A		60			
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C) $V_{GE} = 15V$			30		
T <sub>r</sub>	Rise Time				12		ns
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 400V$ $I_C = 30A$		80			
$T_{f}$	Fall Time	$R_G = 6.8\Omega$		15			
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (125°C) $V_{GE} = 15V$ $V_{Bus} = 400V$ $I_C = 30A$ $R_G = 6.8\Omega$			32		ns
Tr	Rise Time				12		
T <sub>d(off)</sub>	Turn-off Delay Time				90		
$T_{\rm f}$	Fall Time				21		
Eon	Turn-on Switching Energy	$V_{GE} = 15V$ $V_{Bus} = 400V$	$T_j = 125^{\circ}C$		0.3		
E <sub>off</sub>	Turn-off Switching Energy	$I_{\rm C} = 30 \text{A}$ $R_{\rm G} = 6.8 \Omega$	$T_j = 125^{\circ}C$		0.8		mJ

# Reverse diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			600			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =600V	$T_j = 25^{\circ}C$			25	μA
IRM			$T_{j} = 125^{\circ}C$			500	μл
$I_{\rm F}$	DC Forward Current		$Tc = 80^{\circ}C$		25		А
	Diode Forward Voltage	$I_F = 25A$			1.8	2.2	
V <sub>F</sub>		$I_F = 50A$			2.2		V
		$I_F = 25A$	$T_j = 125^{\circ}C$		1.6		
t <sub>rr</sub>	Reverse Recovery Time	1 054	$T_j = 25^{\circ}C$		30		ns
۰rr		$I_{\rm F} = 25 A$ $V_{\rm R} = 400 V$	$T_j = 125^{\circ}C$		175		115
Q <sub>rr</sub>	Reverse Recovery Charge	$di/dt = 200 \text{ A}/\mu \text{ s}$	$T_j = 25^{\circ}C$		55		nC
Zrr	Reverse Receivery Charge		$T_{j} = 125^{\circ}C$		485		inc

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# Thermal and package characteristics

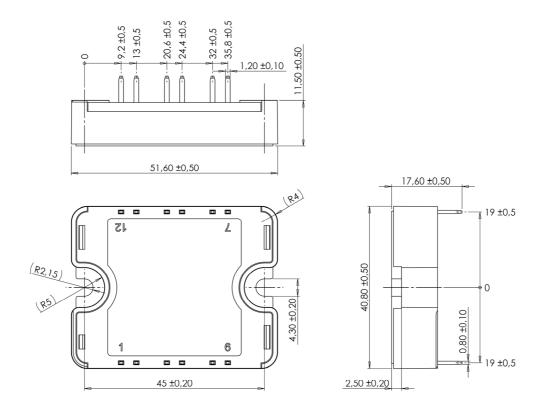
Symbol	Characteristic			Ν	Min	Тур	Max	Unit
R <sub>thJC</sub>	Junction to Case Thermal Resistance		IGB	Т			0.9	°C/W
	sunction to Case Therman Resistance		Dio	de			1.4	1.4 C/ w
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4	000			V
T <sub>J</sub>	Operating junction temperature range			-	-40		150	
T <sub>STG</sub>	Storage Temperature Range			-	-40		125	°C
T <sub>C</sub>	Operating Case Temperature						100	
Torque	Mounting torque	To heatsin	nk N	М4	2		3	N.m
Wt	Package Weight						80	g

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

## **SP1 Package outline** (dimensions in mm)

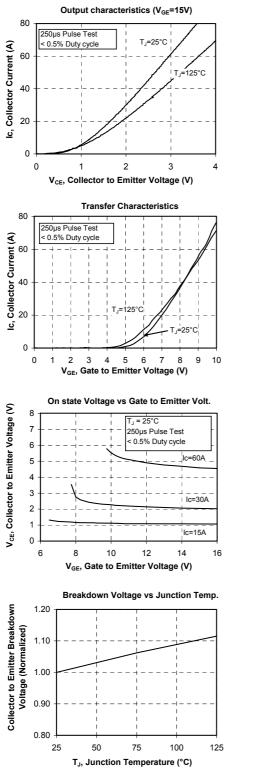


See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

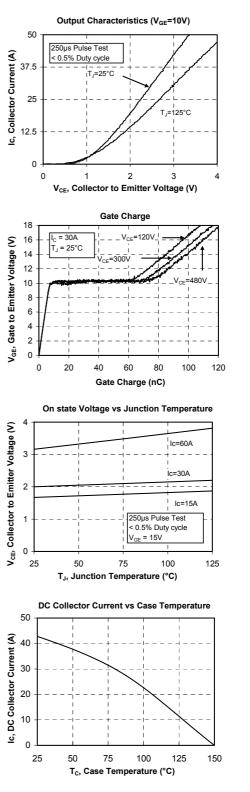
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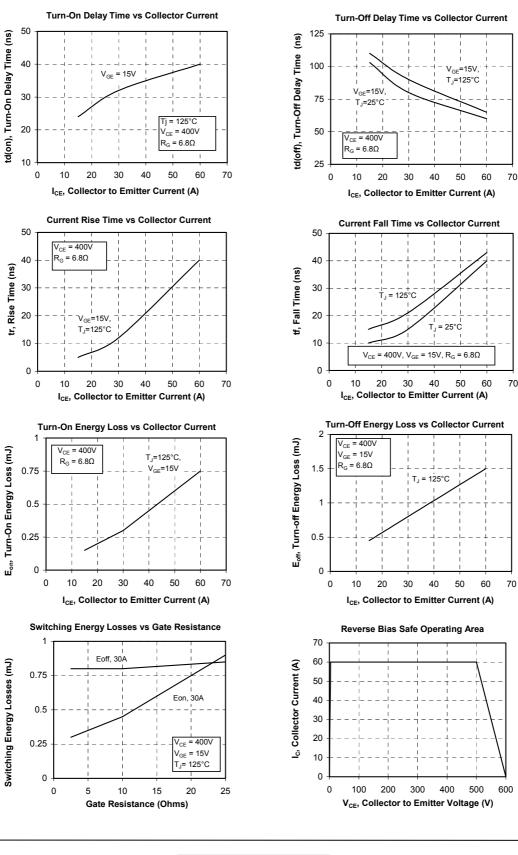
# **Typical Performance Curve**



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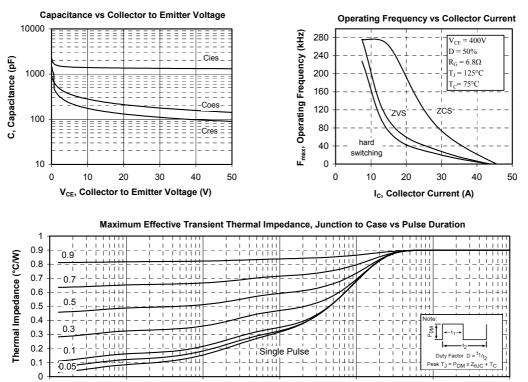
0.00001

0.0001

# APTGF30H60T1G

1

10



0.001 0.01 0.1 Rectangular Pulse Duration (Seconds)

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